Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/746,490	BENDAK ET AL.
Examiner	**Art Unit**
John L. Shew	2664

SEARCHED

Class	Subclass	Date	Examiner
370	350,370	5/16/2005	JS
	395.5		
	401,466		
	467,503		
	505		
	509-517		
	527,529		
375	356-357	5/16/2005	JS
	359,362		
	365,366		
	368		
714	775,776	5/16/2005	JS
	789		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
370	510	5/16/2005	JS
375	366	5/16/2005	JS
714	789	5/16/2005	JS

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR